Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/601,596	CHANG ET AL.
Examiner	Art Unit
PAUL T. CHIN	3652

SEARCHED				
Class	Subclass	Date	Examiner	
294	99.1	9/26/2005	PTC	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
Text search (EAST) attached	9/27/2005	PTC